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Electronic transport in chemical vapor  
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Quantum Hall effect and weak  
localization (vol 96, 122106, 2010)

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**Erratum “Electronic transport in chemical vapor deposited graphene synthesized on Cu: Quantum Hall effect and weak localization”**  
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This erratum is for correcting the affiliations of authors Qingkai Yu, W. Wu, Z. Liu, J. Bao, and S. S. Pei. Corrected affiliations are listed above.

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